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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2811

Examiner: Quang D. Vu

In re PATENT APPLICATION of

Applicant(s) : Kazutaka SHIBATA)

Appln. No. : 10/608,016)

Filed : June 30, 2003)

For : SEMICONDUCTOR DEVICE AND)
MANUFACTURING METHOD)
THEREOF)

Atty. Dkt. : AI 288)

**INFORMATION
DISCLOSURE
STATEMENT**

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(c), i.e., after a first Office Action on the merits but before Final Rejection and/or Notice of Allowance.

Attached is a copy of one Japanese patent publication corresponding to U.S. Patent Application Publication No. 2002-0041013 and cited in a Japanese Office Action dated January 31, 2006 in connection with a Japanese Patent Application No. 2002-230484. Any relevance of the publications may be gleaned from the published U.S. application. The documents are listed on the attached Form PTO-1449.

It is certified that each item of information contained in this Information Disclosure Statement was first cited in a communication from any foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

Respectfully submitted,

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February 13, 2006
Date

SMR:pjl

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty Docket AI 288		Application No. 10/608,016	
				Applicant Kazutaka SHIBATA			
				Filing Date June 30, 2003		Group Unit 2811	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date
	AA	2002/0041013	04/11/02	WAKAMIYA et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub- Class	Trans- lation
	AL	2002-118199	04/19/02	Japan			
	AM						
	AN						
	AO						
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AP						
	AQ						
	AR						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							